

ACRONYMS AND ABBREVIATIONS

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| 2FXO/GT | Two-wire Foreign Exchange Office End with Gain Transfer Unit |
| 4EM | four-wire E and M |
| ACO | alarm cutoff |
| ACU | alarm control unit |
| A/D | analog-to-digital |
| AGC | automatic gain control |
| ALM DET | alarm detector |
| ALM DISAB | alarm disable |
| ALM | alarm |
| ANI | automatic number identification |
| APD | avalanche photodiode |
| ARFAL | digroup A frame alarm |
| ARPCM | digroup A receive pulse code modulation |
| AR | red alarm |
| ATPAM | digroup A transmit pulse amplitude modulation |
| ATPCM | digroup A pulse code modulation |
| AY | yellow alarm |
| B6ZS | binary six zero substitution |
| BIL | buried injector logic |
| BOC | Bell operating company |
| BRFAL | digroup B frame alarm |
| BRPCM | digroup B pulse code modulation |
| BRPCM | digroup B receive pulse code modulation |
| BTPAM | digroup B pulse amplitude modulation |
| CAD | computer-aided design |
| CBIC | complementary bipolar integrated circuit |
| CCIS | common-channel interoffice signaling |
| CGA | carrier group alarm |
| CH | channel |
| CMOS | complementary metal oxide semiconductor |
| CO | central office |
| CODEC | coder-decoder |
| COT | central office terminal |
| CSU | channel service unit |
| CTU | channel test unit |
| CU SIM | channel-unit simulator |
| CU | channel unit |
| CUT | channel under test |
| D4MB | D4 Maintenance Bank |
| DAC | digital-to-analog converter |
| DACS | digital access and cross-connect system |

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|------------------------|---|
| D/A | digital-to-analog |
| dBrnC0 | dB above reference noise, measured with C-message weighting at 0 transmission level point |
| dBTL | decibels-transmission level |
| DCLK | destuffed clock |
| DDS | Digital Data System |
| DEMUX | demultiplexer |
| DF | distribution frame |
| DIF | digital interface frame |
| DIP | dual in-line package |
| DLU | data link unit |
| DS1 | digital signal one |
| DS0 | digital signal zero |
| DSA | digital serving area |
| DSU | data service unit |
| EBES | Electron-Beam Exposure System |
| EEE | electronic equipment enclosure |
| EFS | error-free seconds |
| EIA | Electronic Industries Association |
| EQL | equalizer |
| ESS | electronic switching system |
| FET | field-effect transistor |
| FF | flip-flop |
| FL | fault locate |
| FL/OW | fault locate/order wire |
| FS | signaling, frame signal pattern |
| FT | terminal frame signal pattern |
| HIC | hybrid integrated circuit |
| IC | integrated circuit |
| IIL (I ² L) | integrated injection logic |
| ITS | integrated timing supply |
| JFET | junction field-effect transistor |
| LB | loopback code |
| LBO | line build-out network |
| LCIE | lightguide cable interconnection equipment |
| LC | inductor-capacitor |
| LCLK | loop clock |
| LED | light-emitting diode |
| LIU | line interface unit |
| LL | line loop |
| LOSP | loss of pulse code modulation |
| LPCM | loop pulse code modulation |
| LPF | low-pass filter |
| LSB | least significant bit |

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|--------|--|
| LSI | large-scale integration |
| LSL | logic simulation language |
| LSU | line switching unit |
| LT | loop terminal |
| LTS | local timing supply |
| MB ALM | maintenance bank alarm unit |
| MBTS | maintenance bank test sets |
| MC | multichannel |
| MCLK | multiplexer clock |
| MEM | memory |
| MLT | mechanized loop testing |
| MON | monitor |
| MOS | metal oxide semiconductor |
| MTS | Message Telephone Service |
| MUX | multiplexer |
| NEBS | New Equipment Building System |
| NMOS | n-channel MOS |
| NRZ | nonreturn to zero |
| NTS | nodal timing supply |
| OCUDP | office channel unit dataport |
| OCU | office channel unit |
| OIU | office interface unit |
| OOF | out-of-frame |
| ORU | office receiving unit |
| OS | out of service |
| OTU | office transmitting unit |
| PAM | pulse amplitude modulation |
| PCM | pulse code modulation |
| PCU | power converter unit |
| PDU | power distribution unit |
| PGTC | Pair Gain Test Controller |
| PLL | phase-locked loop |
| PMOS | p-channel MOS |
| POTS | plain old telephone service |
| RCLK | read clock |
| RCLK | receive clock |
| RC | resistor-capacitor |
| RFA | receive frame signal for digroup A |
| RFB | receive frame signal for digroup B |
| RNB2 | receive, negated bit 2 |
| RNPCM | receive, negated pulse code modulation |
| RPAM | receive pulse amplitude modulation |
| RPCM | receive pulse code modulation |
| RT | remote terminal |

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|--------|---------------------------------------|
| RTV | room temperature vulcanization |
| RU | receive unit |
| SBC | standard buried collector |
| SCC | switching control center |
| S/D | signal-to-distortion |
| SDPO | 2-wire sleeve dial pulse originating |
| SIC | silicon integrated circuit |
| SIP | single in-line package |
| SMAS | Switched Maintenance Access System |
| SR | stuff request |
| SSI | small-scale integration |
| SS | special service |
| STAR | standard tantalum active resonator |
| STC | serving test center |
| STS | secondary timing supply |
| SUM | summing |
| SU | synchronizing-desynchronizing unit |
| syndes | synchronizing-desynchronizing |
| T1FP | T1DM framing pattern |
| T6CLK | transmit 6-megahertz clock |
| TAU | time assignment unit |
| TCLK | transmit clock |
| TED | transmission equipment DIP |
| TNEN | transmit, negated enable |
| TOGA | transmit outgoing alarm |
| TPAM | transmit pulse amplitude modulation |
| TPCM | transmit pulse code modulation |
| TPD | trunk processing delayed |
| TPM | trunk processed memory |
| TP | trunk processing |
| TPU | trunk processing unit |
| TPW | trunk processing wink |
| TRU | transmit/receive unit |
| TSI | time-slot interchanger |
| TTL | transistor-transistor logic |
| TU | transmit unit |
| UTE | unitized bay |
| VCO | voltage-controlled oscillator |
| VCXO | voltage-controlled crystal oscillator |
| VFDT | voice-frequency detector |
| VF | voice frequency |
| XO | crystal oscillator |
| ZS | zero suppression |